

<b>Notice of References Cited</b>	Application/Control No. 09/802,464	Applicant(s)/Patent Under Reexamination BAWOLEK ET AL.	
	Examiner José R Díaz	Art Unit 2815	Page 1 of 1

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	B	US-5,274,250 A	12-1993	Miyake et al.	257/59
	C	US-5,854,091 A	12-1998	Back et al.	438/70
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

FORM PTO-892		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		SERIAL NO. <b>09/524,081</b>	GROUP ART UNIT <b>2815</b>	ATTACHMENT TO PAPER NO.	36973 U.S. PTO 09/802461 03/609/03
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*	B	5,506,430	Ohzu	257	292		
*	C	5,962,906	Liu	257	432		
	D	5,576,239	Hatano et al.	438	69		
*	E	6,137,634	Li	359	619		
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*	H	5,719,074	Hawkins et al	438	70		
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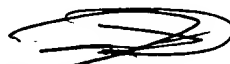
  

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EXAMINER <b>José R. Díaz</b>	DATE <b>January 4, 2001</b>	 Form 892ccs2106b
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FORM PTO-892		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		SERIAL NO. 09/524,081	GROUP ART UNIT 2815	ATTACHMENT TO PAPER NO. 7	
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José R. Díaz			January 4, 2001				
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D	✓ 5,506,430	4/9/96	Ohzu	267	282
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